



PATENT APPLICATION

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re the Application of

Susumu UEHARA et al.

Group Art Unit: 1755

Application No.: 10/733,303

Examiner: K. GROUP

Filed: December 12, 2003

Docket No.: 118052

For: OPTICAL GLASS

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

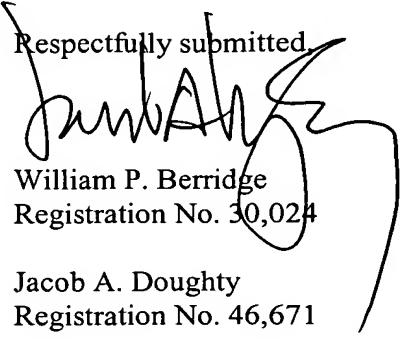
Sir:

Pursuant to 37 CFR §1.56, the attention of the Patent and Trademark Office is hereby directed to the references listed on the attached PTO-1449. Unless otherwise indicated herein, one copy of each reference is attached. It is respectfully requested that the information be expressly considered during the prosecution of this application, and that the references be made of record therein and appear among the "References Cited" on any patent to issue therefrom.

- ☒ 1. This Information Disclosure Statement is being filed with a Request for Continued Examination. No certification or fee is required.
- ☒ 2. An English language Abstract of one or more non-English language reference is attached hereto. See References 1-4.

- ☒ 3. A computer-generated English language translation of one or more Japanese Patent Publication cited herein has been obtained from the website of the Japanese Patent Office ([<http://www.jpo.go.jp>]), and is attached, but has not been reviewed for accuracy. See Reference 4.

Respectfully submitted,


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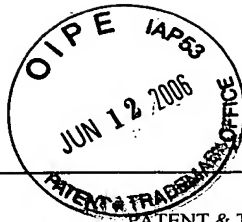
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Date: June 12, 2006

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Sheet 1 of 1

Form PTO-1449
(REV. 1/06)US Dept. of Commerce
PATENT & TRADEMARK OFFICEATTY DOCKET NO.
118052APPLICATION NO.
10/733,303

INFORMATION DISCLOSURE STATEMENT

(Use several sheets if necessary)

APPLICANTS
Susumu UEHARA et al.FILING DATE
December 12, 2003GROUP
1755

U.S. PATENT DOCUMENTS

Examiner Initials	Cite No.	Document Number	Date	Name

FOREIGN PATENT DOCUMENTS

Examiner Initials	Cite No.	Document Number	Date	Country	With English Abstract	With English Translation
	1.	JP 53-47368	12/20/1978	JAPAN	X	
	2.	JP 54-6242	03/27/1979	JAPAN	X	
	3.	JP 54-2646	02/10/1979	JAPAN	X	
	4.	JP 2002-284542	10/03/2002	JAPAN	X	X

OTHER DOCUMENTS

Examiner Initials	Cite No.	(Including Author, Title, Date, Pertinent Pages, etc.)

EXAMINER

DATE CONSIDERED

Examiner: Initial if citation considered, whether or not citation is in conformance with M.P.E.P. 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Date: June 12, 2006